


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537467	<b>Applicant(s)/Patent Under Reexamination</b>  HEMING ET AL.
	<b>Examiner</b>  MARK S KAUCHER	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
525	90, 92r, 93, 94, 95, 96	10/20/2009	MK
524	846, 800, 801	10/20/2009	MK
264	4.1, 4.3	10/20/2009	MK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	10/20/2009	MK
Inventor (eDAN)	10/20/2009	MK
Google search (with respect to polymer comprising cited onomers)m	10/20/2009	MK
STN Structure search	10/20/2009	MK
Reviewed search strategies of Application 10/480405	10/20/2009	MK
Reviewed ISR	10/20/2009	MK
EAST (updated)	3/11/2010	MK
Inventor (updated)	3/11/2010	MK
EAST (updated)	6/24/2010	MK
Inventor (updated)	6/24/2010	MK
EAST (updated)	10/21/2010	MK
Inventor (updated)	10/21/2010	MK
EAST (updated)	4/7/2011	MK
Inventor (updated)	4/7/2011	MK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/MARK S KAUCHER/ Examiner.Art Unit 1764	
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